Parabolic lithium refractive optics for X-rays.

N. R. Pereira

Ecopulse Inc., P.O. Box 528, Springfield, VA 22150*

E. M. Dufresne, R. Clarke

Department of Physics and MHATT-CAT,

University of Michigan, Ann Arbor, MI 48109-1120[†]

D. A. Arms

Advanced Photon Source and MHATT-CAT, Argonne, IL 60439

(Dated: August 21, 2003)

Abstract

For X-rays around 10 keV lithium metal promises to give the highest performance refractive optics. One of the best compound refractive lens designs¹ is now produced routinely in aluminum, and more recently has been demonstrated using beryllium.² Here we report a similar refractive lens made from lithium. At 10.87 keV this lens has a $\simeq 2$ m focal length, more than 90 % peak transmission and an average transmission of 49%. The lens shows a very useful gain of up to 40. The full widths at half-maximum of the focus are blurred by roughly 20 μ m, resulting in a horizontal and vertical FWHM of 33 and 17 μ m for an image distance of 2.13 m. The lens produces speckle on the X-ray beam, which is likely due to the inhomogeneities of the lens surface: coherent X-ray scattering is useful in understanding imperfections in X-ray optics such as mirrors and lenses. Better molding techniques should result in improved performance and enable microbeam techniques with this type of Li lens.

PACS numbers: PACS number(s):

I. INTRODUCTION.

Over the last decade several groups have developed X-ray refractive optics, such as prisms and lenses, that are fully analogous to those for visible radiation. The index of refraction for X-rays is $n=1-\delta+i\beta$, where δ is the index of refraction decrement and β the absorption coefficient^{3,4}. The real part of the index of refraction for X-rays, $Re(n)=1-\delta$, is less than unity by a minute amount δ on the order of 10^{-5} or 10^{-6} . Each prism or lens surface deflects the radiation over an angle α that is proportional to $\pm \delta$. For visible light the index of refraction is larger than unity and δ is typically -0.5 or so, so that for visible light a single prism or lens already gives a useful deflection. In contrast, the deflection of X-rays by a single prism or lens is very weak and only marginally useful.⁵⁻⁷ However, N identical elements in a row deflect over an angle $\propto N\delta$, which for $N \simeq 100$ gives very interesting X-ray optics. These include the Compound Refractive Lenses (CRLs) first implemented by Snigirev et al.,⁸ and further developed by those authors and others^{1,9,10}, and the multiprism lens first implemented by Cederstrom et al.^{11,12}. They are most useful for the highly collimated X-ray beams on advanced synchrotron X-ray sources, but might also be of value for manipulating X-rays from standard lab sources or the new generation of laser-based point sources¹³.

The figure of merit for a material in an X-ray refractive optic is conveniently measured by the phase shift per attenuation length⁷, i.e., the energy-dependent ratio $\delta/2\beta$ between the real and imaginary decrements of the refractive index $n=1-\delta+i\beta$. Radiation with an electric field $E \propto \exp[i(kx-\omega t)]$ incident from the vacuum propagates in the material with a wavevector nk. The real part of the refractive index decrement $n=1-\delta$ gives an additional phase factor $\exp[i(n-1)kx] = \exp(-ik\delta x)$, while the electric field amplitude $\propto \exp(-k\beta x)$ decreases by a factor 1/e over a distance $1/(k\beta)$ due to the index of refraction's imaginary part $i\beta$. The transmitted X-ray intensity is proportional to $|E|^2$, thus the absorption length of the intensity is $\ell_{abs} = 1/(2k\beta)$, hence the radiation shifts its phase by $\Delta\Phi = k\delta\ell_{abs} = \delta/(2\beta)$ in an absorption length. For room-temperature solids lithium has the highest δ/β . Therefore, a particular refractive X-ray lens geometry should have the best performance when it is made from lithium.

The first lithium lens^{14–16} used Cederstrom's multiprism lens geometry because of its ease of manufacturing and the fact that its focal length is conveniently adjustable by tilting the multiprism structure with respect to the beam. This is probably the most useful geometry

for beamline optics since it provides an adjustable focal length, and thus does not require any handling of Li to change the focal length. Two dimensional focusing is possible with perpendicularly placed multi-prism lenses,¹⁷ but to optimally focus a synchrotron beam in two dimensions the best CRL design is that developed by Lengeler's group at Aachen University.^{1,9,18,19}

This paper presents results for a deep parabolic lithium lens close to the Aachen design. Recently another group demonstrated the first parabolic X-ray lenses made from lithium²⁰. They focused 7 and 8 keV X-rays from a second generation synchrotron source with 335 coins of radius of curvature 0.95 mm. We describe here work performed at a third generation synchrotron source with lenslets having a radius of curvature of 0.263 mm. The brilliance of the source is used to determine the lens performance through the use of coherent X-ray scattering techniques.

For deep parabolic lenses the usual material is aluminum¹, although lenses from beryllium have recently been made; they work well². These CRLs are now good enough to take conventional optics applications such as imaging and microscopy into the X-ray regime.^{19,21} Our lithium lenses need further improvements before we can apply them to micro-imaging, but the lenses are already quite useful for focusing the X-ray beam for typical diffraction experiments at fixed X-ray energy.

One prototype lens has N=80 individual lenslets, each with two parabolic surfaces of nominal radius of curvature $R_0 \simeq 0.263$ mm. In each lenslet the lithium is held in the center of a steel washer. The lithium is pressed around two parabolic dies into two opposing parabolas. Each lithium parabola is just under 0.5 mm high at the 1 mm diameter aperture. The two parabolic imprints are nominally separated by a dead layer $d \simeq 50$ to 100μ m thick, making the lenslets slightly thicker than 1 mm and the total lens 100 mm long.

The mechanical mount of the lenslets is similar to that of Ref. 9. Li lenslets are housed in a glass tube filled with He gas, and X-rays are transmitted through two 127 μ m beryllium windows. Although at first the lithium was kept in vacuum¹⁵ it is just as effective and easier to protect lithium with a He atmosphere. In fact, lithium has remained clean for over a year under argon in a glass container with a simple screw top.

The measurement setup is straightforward. X-rays on the Advanced Photon Source (APS) beam line 7-ID are monochromatized by a liquid nitrogen cooled double crystal Si (111) monochromator, typically detuned by 50% to suppress the third harmonic contamination²².

In front of the lens is a pair of limiting slits, and behind the lens is an ionization chamber that measures the lens X-ray transmission. A helium-filled flight path closed off with 12 μ m kapton foils follows the ion chamber. The X-rays excite a cerium-doped YAG crystal whose visible scintillation is imaged via a 5× microscope (Mitutoyo MPlan-APO long working distance objectives with X1 tube lens) coupled to a 12-bit CCD camera (Roper CoolSNAP CF). The camera has 1392 by 1040 pixels that are 4.65 μ m square. With the five-fold magnification used to observe the scintillator light, the camera's field of view is 1.29 mm by 0.97 mm. The setup can quickly focus the beam and also provide quantitative data of the lens performance: it is discussed in detail elsewhere¹⁷.

The lens' focal length $f = R_0/(2N\delta) \propto (h\nu)^2$ varies quadratically with photon energy $h\nu$, so that the scintillating screen can be at a convenient position while the X-ray energy is adjusted to get the image at the right distance. The X-ray source-to-lens distance is $d_s = 49.2$ m, the lens-image distance is $d_i = 2.13$ m, thus the focal length $f = (1/d_i + 1/d_s)^{-1} \simeq 2.04$ m. The calculated photon energy to get this focal length is $h\nu = 10.87$ keV.

Typical results of imaging the X-ray profile on the scintillator are shown in Fig. 1 without the lens, and in Fig. 2 with the lens. The two Figures' spatial scale are the same, but the intensity scale is chosen for best visibility.

The small spot behind the lens in Fig. 2 is a focused image of the source. It is approximately 23-fold more intense than the peak intensity of the original X-ray beam in Fig. 1 and approximately 40 times higher than the unfocused beam's average intensity. These two figures demonstrate that the lens gives a very useful gain, but also shows some imperfections in the focused image: the focal spot is larger than it should be, and in addition it has a halo.

The synchrotron beam²³ in Fig. 1 is apertured by a 500 μ m square slit, placed 120 mm in front of the lens in order to prevent overfilling the lens' 1 mm circular aperture. On the scintillator screen 2.25 m behind the slits the beam is magnified by the geometrical projection, to 523 μ m square. The measured beam size is consistent with this projection. Temporally the beam is very stable on the milli-second time scale needed to gather an image, but spatially the X-ray pattern is quite non-uniform. The striations are likely due to phase shifts caused by the presence of several X-ray Be and kapton windows in the beamline and in the set up²⁴, as well as potential phase shifts generated by the monochromator surfaces. The resulting intensity variations are largely horizontal, consistent with the X-ray source's small size in the vertical direction. In the upper right the beam's local intensity is up to $3\times$

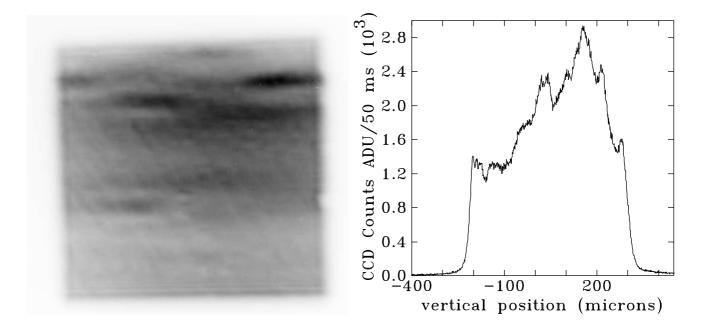


FIG. 1: (left image) Inverted gray scale image (black is the highest intensity) of the square beam, 0.51 (V) by 0.53 (H) mm X-ray beam at 10.87 keV, unfocused. (right) A typical vertical slice of the image, near the undulator beam center.

more than in the beam's striation-less region in the lower half: the average intensity across the beam is about 52 % of the peak image intensity. This may have an effect on the ultimate focal spot and the focal profile.

Multiple Fresnel fringes visible at the beam's lower edge are consistent with a beam whose coherence length is larger vertically than horizontally. Tails above and below the edge are likely due to diffraction from the sharp edges(see vertical slice of Fig. 1). Note that the right and left edges in the image are blurred due to the larger horizontal source size. It is unknown what causes the barely visible cross-wise intensity variations, or how much the upstream initial phase shifts affect the final focus.

The focal length f for a CRL with N double parabolas with radius of curvature R_0 in a material with index of refraction decrement δ is $f = R_0/(2N\delta)$. For our lens N = 80 and $R_0 \simeq 263 \ \mu\text{m}$. At 10.87 keV the data from X-ray tables²⁵ for lithium's δ vary from $\simeq 0.805 \times 10^{-6}$ to 0.811×10^{-6} , hence $f \simeq 2.02$ m to 2.04 m. The source is $d_s \simeq 49.2$ m in front of the lens, whence the image should be $d_i = (1/f - 1/d_s)^{-1} \simeq 2.10$ m to 2.13 m behind the lens. The lens' actual radius of curvature R has not been independently measured and is probably a more important unknown. All distances are measured from the lens center, with

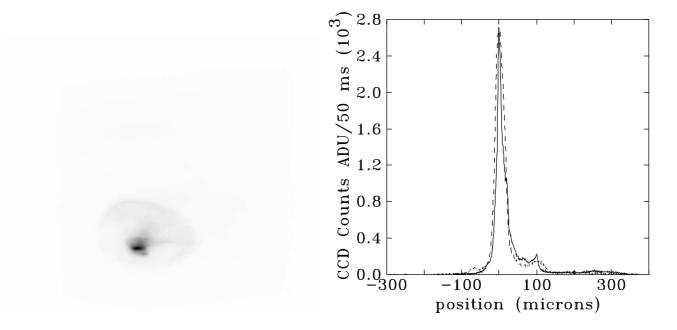


FIG. 2: (left) An inverted gray scale image of the focused X-ray beam in the lens' image plane with the same CCD exposure as Fig. 1. Several Al foils reduce the intensity by a factor 24. (right) Cross-sections through the focus, along x (dashed) and y (solid). The pixel size is 0.93 μ m. The image horizontal and vertical FWHM is 33 and 17 μ m respectively.

the 0.1 m length of the lens neglected.

Adjusting the X-ray energy tends to shift the beam's position, demanding further alignment in either the beam or the diagnostics. Therefore, the data in this paper are taken with the screen at the best location as calculated, 2.13 m behind the lens. No further adjustments were made to find the best image distance experimentally, despite the original intent.

Fig. 2 is the scintillation pattern from X-rays transmitted through the lens. The most intense spot is a demagnified image of the X-ray source that is less than 30 μ m wide and 20 μ m high. The image proper is embedded in a $\simeq 50~\mu$ m region with irregular shape and surrounded by a low intensity, egg-shaped caustic that extends out to 200 μ m or 300 μ m. The cross sections through the image in Fig. 2 show the image's quantitative details, dashed for the cross section along x and solid for the cross section along y. In the x-direction the image profile is reasonably Gaussian because the irregular stray intensity around the peak happens to be slightly displaced from the image proper. However, the cross section through the peak in the y-direction goes through the lower intensity X-rays. The caustic and satellites are visible in the slices of Figure 2: their intensity is at most 10 % of the peak.



FIG. 3: X-ray beam apertured to 10 μ m square (left) and its images (center and right).

The image's $\simeq 33~\mu m$ horizontal width (FWHM) is roughly consistent with but still 60 % larger than expected from the $M=d_s/d_i\simeq 23$ -fold demagnification of the X-ray source. Its FWHM is 478 μm ,²³ so that the image should have a 21 μm FWHM. A demagnified image of the source's height (45.5 μm FWHM) would be 2.0 μm , but the FWHM height in Fig. 2 is $8.6 \times$ larger, $\simeq 17 \mu m$, and inconsistent with the 23-fold demagnification.

The discrepancy is consistent with a small random displacement to the ideal image, so that the demagnified image of the source convolved in quadrature with the random displacement gives the actual image. In the vertical the random displacement is much larger than the ideal image (2 μ m), hence the random component is basically equal to the 17 μ m vertical size. In the horizontal the random displacement is comparable to the ideal image's FWHM (21 μ m). Adding the two in quadrature suggests a real image with a 27 μ m FWHM, only 20 % smaller than measured. The actual image in both directions, vertical and horizontal, is then consistent with a blurring with the same $\sim 17 \mu$ m displacement in both directions. Such a random displacement could be caused by random imperfections in the lens figure.

Imaging is not at fault. The YAG-CCD camera system has a spatial resolution of about $4 \mu m$. In principle the phase shifts visible in the striations of the incoming X-ray beam (Fig. 1) could cause the image to become larger, and the asymmetric profile of the incoming beam could also result in poorer focusing. However, imperfections in manufacturing the lens are clearly the main culprit.

Fig. 3 compares the image of an X-ray beam apertured to 10 μ m by slits 2.25 m before the screen (left) with images of this minute beam focused by different locations on the lens. Note that the small beam is partially coherent since the transverse coherence lengths of the source at the APS are respectively 5 and 100 μ m horizontally and vertically.²⁶ From a small aperture of width d, one expects a diffraction pattern with a width given approximately by $\lambda R/d$, where R is the aperture-screen distance, and λ the X-ray wavelength. Thus the width of the Fraunhofer diffraction pattern of 10.87 keV X-rays passing through a 10 μ m



FIG. 4: X-ray image of 10 μ m beam(left); with 10× longer exposure time. (right)

slit, and observed 2.25 m away is 26 μ m. Coherent X-rays passing through a sample whose spatial inhomogeneities introduce random phase shifts in the diffracted beam create speckle in the diffraction pattern.²⁶ The speckle pattern is very sensitive to the microstructure of the sample. The width of an individual speckle is the width of the Fraunhofer pattern from a slit with an aperture identical to the illuminated area.

The pinhole image of the incoming beam at the scintillator is about 30 μ m square due to diffraction at the edges, and the phase is uniform across the beam as evident from the absence of striations. The two images to the right are obtained from different locations on the lens. The middle image is quite good: in the horizontal direction it has the expected (30 μ m) width, but in the vertical direction it is just as high as the image obtained from the 500 μ m square beam in Figure 1. The diffracted pattern from the slit is focused by the lens in the middle image. For the spot to the far right the X-rays went through a region of the lens that produces three separated images (taken with twice the 75 ms observation time of the incoming beam and the properly focused image). This can also be viewed as a speckle pattern from the lens illuminated area, which implies that spatial inhomogeneities are present on length scale less than 10 μ m. Superposing imperfect images caused by a poor local surface with good images from other locations on the lens is probably responsible for the irregular region of X-rays around the intense image in Fig. 2. The weak caustic in this Figure must come from rare but major deviations of the ideal lens figure. Improved manufacturing of the lens should alleviate all these problems.

A minor problem, but an invaluable diagnostic, is the lens' small angle scattering. Fig. 4 compares two images of the nominally 10 μ m square beam created by a good spot on the lens surface. The left image is obtained when the CCD is properly exposed during 75 ms, while the right image is heavily overexposed in 750 ms. The pixels in the image proper flow over to give it an apparent height of $\simeq 50~\mu$ m, but the interesting features in the overexposed image are the side lobes. These show a small angle scattering speckle pattern. In the horizontal

their peaks are $\simeq 40 \ \mu \text{m}$ to 60 μm apart, while in the vertical the peaks are a little closer. The characteristic angle θ_s is tens of microradians. Spatial features with dimension d create deflections over an angle $\theta \simeq \lambda/d$, so that θ_s is consistent with a characteristic value for d in the micron range. This weak scattering may also contribute to the overall weak tails seen in Fig. 2.

When the lenslets are made with lithium that has been stored for some time, optical images of lens surfaces do indeed show features of around a few microns. These are most reminiscent of grain boundaries that come out clearly by etching.²⁷ Similar features are very hard to see in lenslets made with fresh lithium that make up the lens tested here, but the presence of similar metallic grains can not be excluded. Any scattering from such inhomogeneities is a small but annoying problem that can be suppressed only with more control over lithium's metallurgy.

Despite the imperfections in the lens, deviations from the ideal figure, local surface quality, or grains, the lens' gain is a very useful $G \simeq 40$. This number is measured somewhat indirectly, by dividing the average intensity of the beam in Fig. 1 with the peak value in Figure 2 corrected for the $T \simeq 0.0414$ X-ray transmission of the Al foil used to give the two images roughly the same exposure. The foils were needed because below a few milli-seconds exposure times the camera does not take reliable pictures. The Al foil thickness (1.016 mm) was measured by a caliper, and its transmission at 10.87 keV was calculated from tables:²⁸ the transmission was not independently measured.

For a non-uniform beam the gain can also be defined by the peak intensities, in which case the gain is only 23-fold. However, a uniform and well centered beam should have the same or perhaps a better image than the lens gives at present, so that the gain definition with the average initial beam intensity seems more relevant. In either case the gain is still very respectable, and very useful. However, the gain is only a fraction of the theoretically possible gain $G = M^2T$ (See Eq. 5 in Ref.²⁰). Here $M \simeq 23$ is the magnification and $T \simeq 0.49$ is the measured overall transmission of X-rays through the lens aperture. The theoretical gain is 259, thus 6.6 times higher than the measured gain (40).

The lower gain is consistent with the larger image in the vertical direction, for which the discrepancy with the ideal image is discussed earlier. Spreading the X-rays over an image that is larger than the ideal by an order of magnitude reduces the theoretical gain by the same order of magnitude. In addition, X-rays that are deflected improperly to stray around



FIG. 5: Focused fundamental X-rays below transmitted higher harmonics.

the main image or form a caustic can not contribute to the peak intensity.

Another factor that influences the gain estimate is the presence of higher harmonics. These were carefully suppressed in the 10.87 keV beam but remained during a short run at a lower energy intended to test another lens with fewer (40) lenslets. The diagnostics can remain at 2.13 m behind the lens if the X-ray energy $h\nu \simeq 10.87$ keV is reduced to $h\nu/\sqrt{2} \simeq 7.69$ keV. However, the N=40 lens focuses better with 7.3 keV where the image in Fig. 5 was taken.

Harmonics in the 7.3 keV beam could not be as carefully suppressed as at 10.87 keV, but harmonic contamination has its advantages. Fig. 5 shows the image of the source made by focusing a 100 μ m square beam in nominally 7.3 keV X-rays with the 40-lenslet lens. The fundamental X-rays at 7.3 keV give substantially the same image as obtained earlier, but the lens barely deflects the harmonics. In Fig. 5 the original beam is between 25 μ m and 100 μ m higher that the lens' optical axis, which is conveniently indicated by the focused image of 7.3 keV X-rays. Clearly, the lens compresses the originally 100 μ m high beam of mostly $3\times7.3\simeq22$ keV photons in the vertical direction by 25% as expected from this geometry. As with the lithium multiprism¹⁶ the lens gives a small X-ray spot that is not only more intense but also lacks higher harmonics.

In conclusion, this paper documents the performance of a deep parabolic coin-type CRL made from lithium. At 10.87 keV the lens provides a very useful gain, nominally 23 or

40 depending on the gain definition. Still, the gain is at least six times less than should be theoretically possible. The discrepancy is caused by imperfections in the lens, some undoubtedly due to the manufacturing process and some possibly intrinsic. Improvements in manufacturing methods should lead to a better lens figure and improved surface quality, but some remnant of small angle scattering may well remain.

A convenient way to measure the quality of the lens is the speckle pattern resulting from coherent X-ray scattering of a small beam. It indicates local inhomogeneities with spatial extent between 1-10 μ m. Coherent X-ray scattering will become the technique of choice to characterize future X-ray lenses and possibly of X-rays optics in general.

Acknowledgments

NRP's work is done with support from MDA through SBIR contract N00178-02-C-3119 and is monitored by the Naval Surface Warfare Center, Dahlgren Division. This work was done at the MHATT-CAT 7ID beamline, and was supported in part by DOE Grant No. DE-FG02-03ER46023 and DE-FG02-00ER15031, and by the NSF FOCUS physics frontier center. Use of the Advanced Photon Source is supported by the U.S. Department of Energy, Basic Energy Sciences, Office of Energy Research, under Contract No. W-31-109-ENG-38.

^{*} Electronic address: pereira@speakeasy.net; URL: http://www.ecopulse.com

[†] URL: http://www.mhatt.aps.anl.gov

¹ B. Lengeler, J. Tuemmler, A. Snigirev, I. Snigireva, and C. Raven, J. Appl. Phys. **84**, 5855 (1998).

 $^{^2\,}$ M. Kuhlmann, et al., to be presented at the 2003 Synchrotron Radiation Conference.

³ A modern account is D. Attwood, Soft X-rays and extreme ultraviolet radiation, (Cambridge University Press, Cambridge, UK 2000).

⁴ Contemporary accounts with references to the original papers are e.g., A. E. Lindl in *Handbuch der Experimentalphysik*, Akademische Verlagsgesellschaft, Inc., W. Wien and F. Harms, Eds, **24**, part 2, 114 (1930); A. H. Compton and S. K. Allison, *X-rays in theory and experiment*, Van Nostrand, 1935; R. W. James, *The optical principles of the diffraction of X-rays*, (reprint:

- Ox Bow Press, Woodbridge, CT), 1948.
- ⁵ S. Suehiro, H. Miyaji, and H. Hayashi, Nature **352**, 385 (1991).
- ⁶ A. G. Michette, Nature **353**, 510 (1991).
- ⁷ B. X. Yang, Nucl. Instrum. and Meth. A **328**, 578 (1993).
- ⁸ A. Snigirev, V. Kohn, A. Snigireva, and B. Lengeler, Nature **384**, 49 (1996).
- ⁹ B. Lengeler, C. Schroer, J. Tuemmler, B. Benner, M. Richwin, A. Snigirev, I. Snigireva, and M. Drakopoulos, J. Synchrotron Rad. 6, 1153 (1999).
- ¹⁰ J. T. Cremer, M. A. Piestrup, H. R. Beguiristain, C. K. Gary, R. H. Pantell, and R. Tatchyn Rev. Sci. Instrum. **70** 3545 (1999).
- B. Cederstrom, R. Cahn, M. Danielsson, M. Lundqvist, and D. Nygren, Nature 404, 951, 2000;
 B. Cederstrom, MS Thesis, see www.particle.kth.se/~ceder/.
- B. Cederstrom, M. Lundqvist, and M. Ribbing, Appl. Phys. Lett. 81, 1399 (2002). B. Cederstrom, PhD Thesis, see www.particle.kth.se/~ceder/.
- ¹³ R.F. Service, News Focus, Science **301**, 154-156 (2003).
- ¹⁴ N. R. Pereira, D. A. Arms, R. Clarke, S. B. Dierker, E. M. Dufresne, and D. Foster, Proc. SPIE 4502, 173 (2001).
- E. M. Dufresne, D. A. Arms, S. B. Dierker, R. Clarke, N. R. Pereira, and D. Foster, Appl. Phys. Lett. 79,4085 (2001).
- ¹⁶ D. A. Arms, E. M. Dufresne, S. B. Dierker, R. Clarke, N. R. Pereira, and D. Foster, Rev. Sci. Instrum. 73, 1492 (2002).
- ¹⁷ E. M. Dufresne, N. R. Pereira, R. Clarke and D.A. Arms, To be presented at the SRI 2003 conference in San Francisco (in preparation).
- ¹⁸ B. Lengeler, C. G. Schroer, B. Benner, A. Gerardus, T. F. Günzler, M. Kuhlmann, J. Meyer, and C. Zimprich, J. Synchr. Rad. 9, 119 (2002).
- ¹⁹ Aachen's website www.xray-lens.de has an excellent account of parabolic CRLs and an up to date series of papers.
- ²⁰ J. T. Cremer, H. R. Beguiristain, M. A. Piestrup, and C. K. Gary, Rev. Sci. Instrum. 74 2262 (2003).
- ²¹ C. G. Schroer, J. Meyer, M. Kuhlmann, B. Benner, T. F. Günzler, B. Lengeler, C. Rau, T. Weitkamp, A. Snigirev, and I. Snigireva, Appl. Phys. Lett 81, 1527 (2002).
- ²² E. M. Dufresne, D.A. Arms, S.B. Dierker, R. Clarke, Y. Yacoby, J. Pitney, B. MacHarrie, and

- R. Pindak, Rev. Sci. Instrum. 73, p1511-1513 (2002).
- http://www.mhatt.aps.anl.gov/dohn/calculators/gives the APS Undulator A beam properties. The machine currently runs with an horizontal emittance of 2.6 nm-rad and a vertical coupling of 2.7 %. The betatron parameters on the site are for a straight section. At 10.87 keV, the horizontal and vertical RMS source sizes are respectively 203 and 19 μ m.
- A. Snigirev, I. Snigireva, V.G. Kohn, S.M. Kuznetsov, Nucl. Instrum. and Meth. A, 370 634-640 (1996).
- The lower number is from the DABAX data base that is part of XOP (a well-known X-ray propagation code available at http://www.esrf.fr/computing/scientific/xop/), while the higher number is from LBL's Center for X-Ray Optics' website www-cxro.lbl.gov.
- ²⁶ E.M. Dufresne, T.S. Nurushev, S.B. Dierker, and R. Clarke, Phys. Rev. E **65** 065107 (2002).
- ²⁷ M. Krystian and W. Pichl, Materials Characterization **46**, 1 (2000).
- The X-ray properties of material properties are conveniently available on the web from Lawrence Berkeley Laboratory's Center for X-ray Optics at www-cxro.lbl.gov.